


<b>Search Notes</b>  	<b>Application/Control No.</b>  10050600	<b>Applicant(s)/Patent Under Reexamination</b>  FUJITA, YOSHITAKA
	<b>Examiner</b>  Hartmann, Kenneth R	<b>Art Unit</b>  2616

SEARCHED			
Class	Subclass	Date	Examiner
370	389, 392, 536, 542-544	05/24/07	KRH

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with SPE, Chau Nguyen	05/24/07	KRH
Performed limited text search of the above subclasses	05/24/07	KRH
Updated Search	11/21/07	KRH
Updated Search	07/18/08	KRH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner